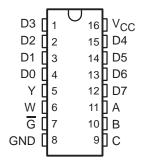
- 8-Line to 1-Line Multiplexers Can Perform as:
  - Boolean Function Generators
  - Parallel-to-Serial Converters
  - Data Source Selectors
- Package Options Include Plastic Small-Outline (D) and Ceramic Flat (W)
  Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J)
  300-mil DIPs

### description

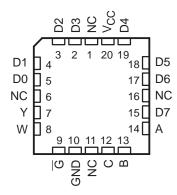
These monolithic data selectors/multiplexers provide full binary decoding to select one of eight data sources. The strobe  $(\overline{G})$  input must be at a low logic level to enable the inputs. A high level at the strobe terminal forces the W output high and the Y output low.

The SN54HC151 is characterized for operation over the full military temperature range of -55°C to125°C. The SN74HC151 is characterized for operation from -40°C to 85°C.

SN54HC151 ... J OR W PACKAGE SN74HC151 ... D OR N PACKAGE (TOP VIEW)



SN54HC151 ... FK PACKAGE (TOP VIEW)



NC - No internal connection

### **FUNCTION TABLE**

	II.	OUTI	PUTS			
,	SELECT	-	STROBE			
С	В	Α	G	'	W	
Х	Χ	Х	Н	L	Н	
L	L	L	L	D0	D0	
L	L	Н	L	D1	D1	
L	Н	L	L	D2	D2	
L	Н	Н	L	D3	D3	
Н	L	L	L	D4	D4	
Н	L	Н	L	D5	D5	
Н	Н	L	L	D6	D6	
Н	Н	Н	L	D7	D7	

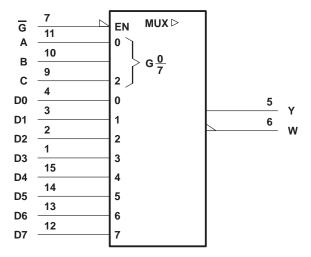
D0, D1  $\dots$  D7 = the level of the respective D input



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



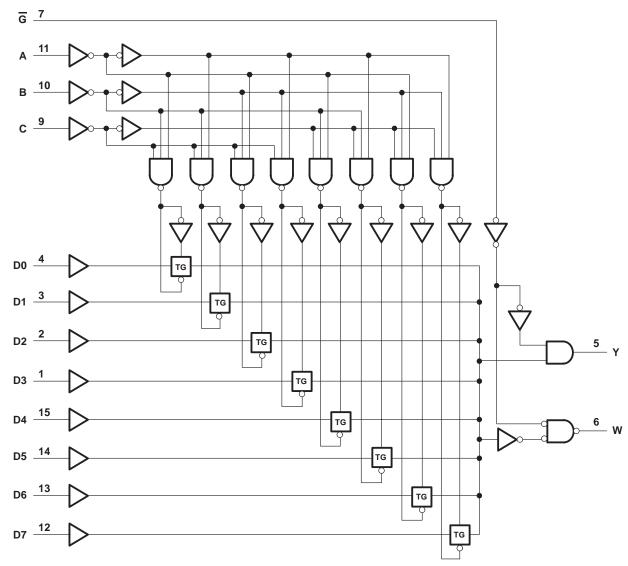
## logic symbol†



 $<sup>^\</sup>dagger$  This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, J, N, and W packages.



## logic diagram (positive logic)



Pin numbers shown are for the D, J, N, and W packages.

## SN54HC151, SN74HC151 8-LINE TO 1-LINE DATA SELECTORS/MULTIPLEXERS

SCLS110C - DECEMBER 1982 - MAY 1997

### absolute maximum ratings over operating free-air temperature range†

Supply voltage range, V <sub>CC</sub>	0.5 V to 7 V
Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0 or V <sub>I</sub> > V <sub>CC</sub> ) (see Note 1)	±20 mA
Output clamp current, I <sub>OK</sub> (V <sub>O</sub> < 0 or V <sub>O</sub> > V <sub>CC</sub> ) (see Note 1)	±20 mA
Continuous output current, $I_O$ ( $V_O = 0$ to $V_{CC}$ )	±35 mA
Continuous current through V <sub>CC</sub> or GND	±70 mA
Package thermal impedance, θ <sub>JA</sub> (see Note 2): D package	113°C/W
N package	78°C/W
Storage temperature range, T <sub>stg</sub>	. −65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

### recommended operating conditions

			SI	N54HC15	51	SN	174HC15	1	LINIT	
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT	
VCC	Supply voltage		2	5	6	2	5	6	V	
		V <sub>CC</sub> = 2 V	1.5			1.5				
$V_{IH}$	IH High-level input voltage	$V_{CC} = 4.5 V$	3.15			3.15			V	
		V <sub>CC</sub> = 6 V	4.2			4.2				
	Low-level input voltage	V <sub>CC</sub> = 2 V	0		0.5	0		0.5		
$\vee_{IL}$		V <sub>CC</sub> = 4.5 V	0		1.35	0		1.35	٧	
		VCC = 6 V	0		1.8	0		1.8		
VI	Input voltage		0		VCC	0		VCC	V	
VO	Output voltage		0		VCC	0		VCC	V	
		V <sub>CC</sub> = 2 V	0		1000	0		1000		
t <sub>t</sub>	Input transition (rise and fall) time	V <sub>CC</sub> = 4.5 V	0		500	0		500	ns	
		VCC = 6 V	0		400	0		400		
TA	Operating free-air temperature	·	-55		125	-40		85	°C	



<sup>2.</sup> The package thermal impedance is calculated in accordance with JESD 51, except for through-hole packages, which use a trace length of zero.

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		Voc	Т	A = 25°C	;	SN54HC151		SN74HC151		UNIT	
PARAMETER	1551 CC	MUITIONS	VCC	MIN	TYP	MAX	MIN	MAX	MIN	MAX	ONII	
			2 V	1.9	1.998		1.9		1.9			
		I <sub>OH</sub> = -20 μA	4.5 V	4.4	4.499		4.4		4.4			
Voн	$V_I = V_{IH} \text{ or } V_{IL}$		6 V	5.9	5.999		5.9		5.9		V	
	I <sub>OH</sub> = -6 mA	4.5 V	3.98	4.3		3.7		3.84		]		
		$I_{OH} = -7.8 \text{ mA}$	6 V	5.48	5.8		5.2		5.34			
			2 V		0.002	0.1		0.1		0.1		
		I <sub>OL</sub> = 20 μA	4.5 V		0.001	0.1		0.1		0.1		
VOL	VI = VIH or VIL		6 V		0.001	0.1		0.1		0.1	V	
		I <sub>OL</sub> = 6 mA	4.5 V		0.17	0.26		0.4		0.33		
			I <sub>OL</sub> = 7.8 mA	6 V		0.15	0.26		0.4		0.33	
lį	$V_I = V_{CC}$ or 0		6 V		±0.1	±100		±1000		±1000	nA	
Icc	$V_I = V_{CC}$ or 0,	I <sub>O</sub> = 0	6 V			8		160		80	μΑ	
C <sub>i</sub>		·	2 V to 6 V		3	10		10		10	pF	

# switching characteristics over recommended operating free-air temperature range, $C_L$ = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	\ \ \	T,	λ = 25°C	;	SN54H	IC151	SN74H	C151	LINUT
PARAMETER	(INPUT)	(OUTPUT)	VCC	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
			2 V		94	250		360		312	
	A, B, or C	Y or W	4.5 V		30	50		73		63	
			6 V		25	43		62		54	
	Any D	Y or W	2 V		74	195		283		244	ns
<sup>t</sup> pd			4.5 V		23	39		57		49	
			6 V		20	33		48		41	
	G	Y or W	2 V		49	127		185		159	
			4.5 V		15	25		37		32	
			6 V		13	22		32		28	
		Y or W	2 V		22	75		110		95	
t <sub>t</sub>			Y or W	4.5 V		9	15		22		19
			6 V		8	13		19		16	

# switching characteristics over recommended operating free-air temperature range, $C_L$ = 150 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	Vaa	T	λ = 25°C	;	SN54H	C151	SN74H	C151	UNIT
PARAMETER	(INPUT)	(OUTPUT)	VCC	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
			2 V		107	350		525		440	
	A, B, or C	Y or W	4.5 V		33	70		105		88	
			6 V		30	59		89		76	ns
<sup>t</sup> pd	Any D	Y or W	2 V		90	275		415		345	
			4.5 V		29	51		83		69	
			6 V		25	47		72		59	
	G	Y or W	2 V		67	205		310		255	
			4.5 V		21	41		62		51	
			6 V		18	35		53		43	
		Y or W	2 V		51	210		315		265	
t <sub>t</sub>			4.5 V		16	42		63		53	ns
			6 V		14	36		53		45	

### operating characteristics, T<sub>A</sub> = 25°C

	PARAMETER	TEST CONDITIONS	TYP	UNIT
C	pd Power dissipation capacitance	No load	70	pF

#### PARAMETER MEASUREMENT INFORMATION VCC From Output Test Input 50% 50% **Under Test Point** $\mathsf{C}_\mathsf{L}$ - tPLH → (see Note A) In-Phase Vон 90% 50% Output **LOAD CIRCUIT ⋖**─ tpHL - Vcc 90% 90% Input 50% 90% Out-of-Phase 50% Output $v_{\mathsf{OL}}$ **VOLTAGE WAVEFORM VOLTAGE WAVEFORMS INPUT RISE AND FALL TIMES** PROPAGATION DELAY AND OUTPUT TRANSITION TIMES

- NOTES: A. C<sub>L</sub> includes probe and test-fixture capacitance.
  - B. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>f</sub> = 6 ns.
  - C. The outputs are measured one at a time with one input transition per measurement.
  - D. tpLH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms



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